SHIGA7.004APC PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Maruyama et al.

Appl. No.

10/522,036

Filed

: January 19, 2005

For

CHEMICAL AMPLIFICATION TYPE POSITIVE PHOTORESIST COMPOSITION AND RESIST PATTERN FORMING METHOD

Examiner

Lee, Sin J

Group Art Unit

1752

## AMENDMENT AND RESPONSE TO OFFICE ACTION

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## Dear Sir:

In response to the final Office Action mailed **September 20, 2007**, please consider the following amendments and remarks.

Amendments to the claims begin on page 2 of this paper.

Remarks begin on page 10 of this paper.